

MAR 29 2004

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 215141US2		SERIAL NO. 09/981,983	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yasuhiro IWAMURA, et al.		GROUP 3641	
				FILING DATE October 19, 2001			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
NO TRANSLATION		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AG	406 40 544 /	06/04/1998	GERMANY			Y
	AR	40 00 604 /	02/20/1992	GERMANY			Y
	AQ	1 202 290	05/02/2002	EUROPE			
	AR						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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AT	Y. IWAMURA, et al., Jpn. J. Appl. Phys., vol. 41, pt. 1, no. 7A, pages 4642-4650, "ELEMENTAL ANALYSIS OF PD COMPLEXES: EFFECTS OF D ₂ GAS PERMEATION", July 2002						
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AW							
AX							
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner /Daniel Greene/					Date Considered 04/13/2008		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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